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566.40596X00

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): T. FUJISHIRO, et al

Serial No.: 09/941,771

Filed: August 30, 2001

For: CERTIFICATE VALIDITY AUTHENTICATION METHOD AND APPARATUS

Group: 2123

Examiner: Not assigned

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INFORMATION DISCLOSURE STATEMENT
UNDER 37 CFR §1.97 & 1.98Assistant Commissioner
for Patents
Washington, D.C. 20231

October 9, 2002

Sir:

In the matter of the above-identified application, applicants are submitting herewith a copy of a communication from a foreign patent office in a counterpart foreign application and copies of the documents listed in the attached form equivalent to Form PTO-1449 for the Examiner's consideration.

This information disclosure statement is being submitted before the mailing date of a first office action on the merits.

Each of the documents listed on the attached form equivalent to Form PTO-1449 is in the English language.

It is respectfully requested that this information disclosure statement be considered by the Examiner.

Please charge any shortage in the fees due in connection with the filing of this paper, including extension of time fees, to the deposit account of Antonelli, Terry, Stout & Kraus Deposit Account No. 01-2135 (566.40596X00) please credit any excess fees to such deposit account.

Respectfully submitted,



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FORM PTO-1449 U.S. Department of Commerce (Rev. 4/92) Patent and Trademark Office		ATTY. DOCKET NO.	SERIAL NO.
		566.40596X00	09/941,771
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		APPLICANT T. FUJISHIRO, et al	
		FILING DATE August 30, 2002	GROUP 2123

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

B. Schneier, "Applied Cryptograph" Applied Cryptograph, Protocols, Algorithms, and Source Code in C, New York, John Wiley & Sons, US, pp. 574-577.

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.